



FORM PTO-1449		Docket Number (Optional) 294G 1787-5		Application Number 10/027,671	
INFORMATION DISCLOSURE CITATION IN AN APPLICATION		Applicant Colbert et al.			
(Use several sheets if necessary)		Filing Date 12/21/2001		Group Art Unit 1754	
U.S. PATENT DOCUMENTS					
EXAMINER INITIAL	DOCUMENT NUMBER	DATE	NAME	CLASS	FILING DATE IF APPROPRIATE
FOREIGN PATENT DOCUMENTS					
	DOCUMENT NUMBER	DATE	COUNTRY	CLASS	TRANSLATION (YES/NO)
	JP H06-331309	12/2/1994	Japan		
	JP H06-252056	9/9/1994	Japan		
	JP H07-122198	5/12/1995	Japan		
OTHER DOCUMENTS (Including Author, Title, Date, Pertinent Pages, Etc.)					
	"Imaging steep, high structures by scanning force microscopy with electron beam deposited tips" by David J. Keller, et al., pages 333-339 in the <i>Surface Science</i> magazine published by Elsevier Science Publishers B.V. in 1992 in Holland				
	"New Scanning tunneling microscopy tip for measuring surface topography" by Y. Akama, et al., pages 429-433 in <i>Vac. Sci. Technol. A 8</i> published by American Vacuum Society in 1990				
	"Atomic force microscopy using ZnO whisker tip" by H. Kado, et al., pages 3330-3332 in <i>Rev. Sci. Instrum</i> 63 published by American Institute of Physics in 1992				
	"Helical microtubules of graphitic carbon" by Sumio Iijima, pages 56-58 in the <i>Nature</i> magazine Vo. 354 published in 1991				
	"Single-shell carbon nanotubes of 1-nm diameter" by Sumio Iijima et al., pages 603-605 in the <i>Nature</i> magazine Vo. 363 published in 1993				
	"Aligned Carbon Nanotube Arrays Formed by Cutting a Polymer Resin-Nanotube Composite" by P.M Ajaya, et al., pages 1212-1214 in the <i>SCIENCE</i> magazine Vo. 265 published in 1994				
	"Aligned Carbon Nanotube Films: Production and Optical and Electronic Properties" by Walt A. de Heer, et al., pages 845-847 in the <i>SCIENCE</i> magazine Vo. 268 published in 1995				
EXAMINER		DATE CONSIDERED			
EXAMINER: Initial if citation considered, whether or not citation is in conformance with MPEP § 609; Draw line through citation if not in conformance and not considered. Include copy of this form with next communication to the applicant.					

Not Considered (After issue fee)